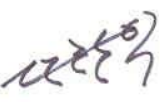
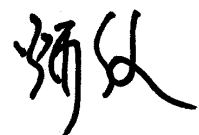


TBBP-A free


MSL Level 1
ROHS-Y

Approval Sheet

Products	Dielectric Chip Antenna		
Customer	Zenocom		
Model	I730		
Customer CODE			
Supplier	PARTRON		
Supplier CODE	ACS2450ICA173		
Zenocom	By designed	By checked	By approved
PARTRON	By designed	By checked	By approved
			
	Research 5 Team	Quality Assurance	Laboratory
	Chanik.Jeon	Nam-Sik. Min	Byoung-Jun.Yim
	02/26	02/26	02/26

2008. 02. 26


22-6 Seokwoo-dong, Hwaseong-si, Gyeonggi-do, Korea 455-300

Tel : 82-31-201-7870~6

Fax : 82-31-201-7800

www.partron.co.kr

TBBP-A free



MSL Level 1

ROHS-Y

SPECIFICATION

MODEL : ACS2450ICAI73

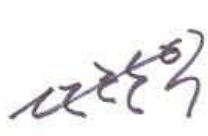
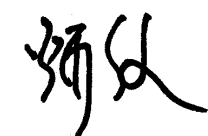
3D Structure



Top View



Bottom View

By designed	By checked	By approved
		
Research 5 Team	Quality Assurance	Laboratory
Chanik.Jeon	Nam-Sik. Min	Byoung-Jun.Yim
02/26	02/26	02/26

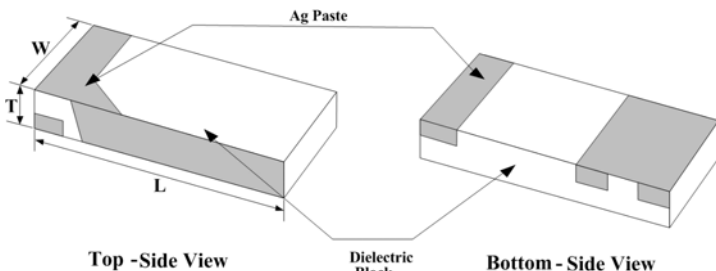
2008. 02. 26

- Contents -

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※ Contents	3 p
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2. Summary of Parts

- This product is the internal dielectric chip antenna of radio communication, forms the pattern with Ag paste on the brick of dielectric block and materializes the characteristics

Type	Only Bulk Ceramic	
Material	Dielectric Block	Mg ₂ SiO ₄ (Magnesium Silicate)
	Electrode Paste	Ag
Size[mm]	W = 3.0±0.1	
	L = 9.0±0.1	
	T = 1.2±0.1	
Flatness Level	0.04	
MSL Level	MSL Level 1	
ESD Level	More than 15 KV (HBM CLASS 3B)	
Version	Revision 1.0	

3. Critical to Quality ()

- The following list is specified as the emphasis management list and managed.

CTQ ITEM	Specification Reason
Shape weight, size	Shape weight and size determines the electric block size after plastic and the dielectric block size effects the level of detail for the printing.
Plastic Size	The size after plastic effects the level of detail for the printing.
Printing Size	The level of detail for printing size is an essential list of the BT antenna.

CTF ITEM	Specification Reason
Single Element measur  t SWR	An important Parameter classifying the electrical characteristics.

- require attention for the following list.

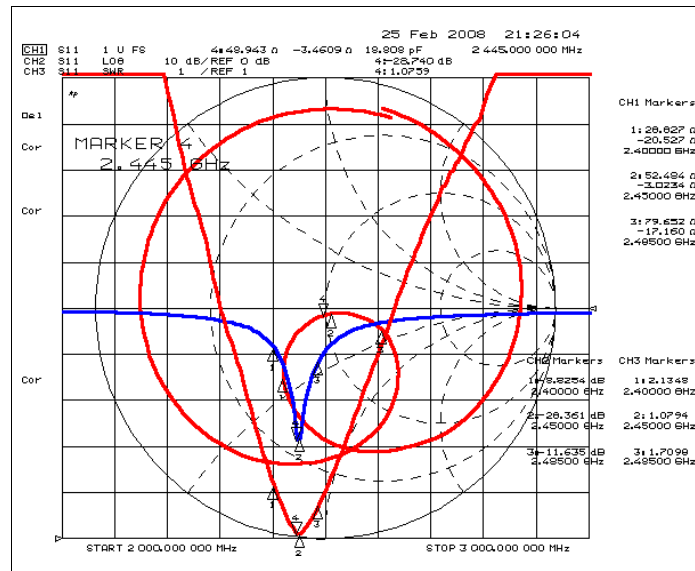
ITEM	Content
Keeping	Sealing tightly when keeping for a long time.
Action	Maybe characteristics changes when changing any design.

4. Electrical Characteristics

4.1 Set Condition

ITEM				SPEC
Frequency Range [MHz]				2400 ~ 2485
SWR [Max]				3.0 : 1 (Typ 2.0 : 1)
Input Impedance [Ω]				50 Ohm
Polarization				Linear
Gain[dBi]	Total Gain (Peak / Avg) [dBi]			-0.7 / -6.9
	Azimuth	Theta	Peak	-3.42
			Average	-7.28
		Phi	Peak	-3.88
			Average	-7.68
	Elevation 1	Theta	Peak	-1.10
			Average	-4.69
		Phi	Peak	-3.64
			Average	-8.22
	Elevation 2	Theta	Peak	-2.65
			Average	-13.40
		Phi	Peak	-0.74
			Average	-4.75

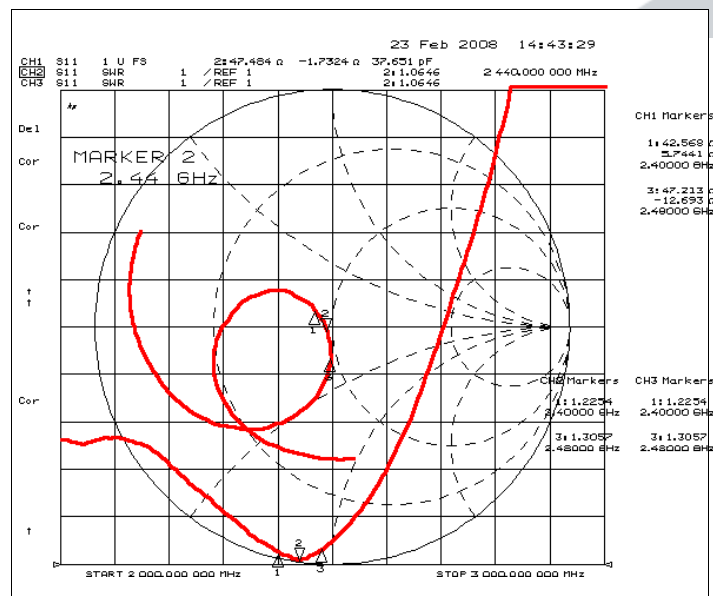
4.2 S11 Graph of Set Condition



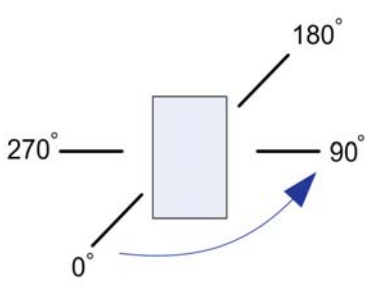
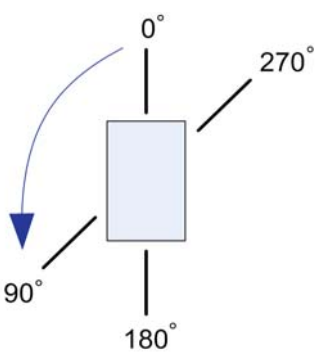
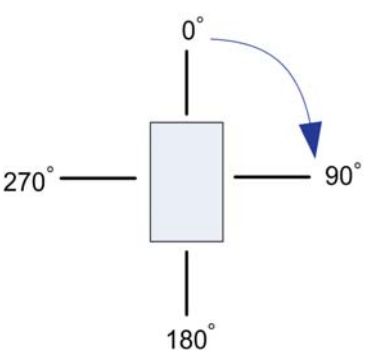
4.3 Test Fixture Condition

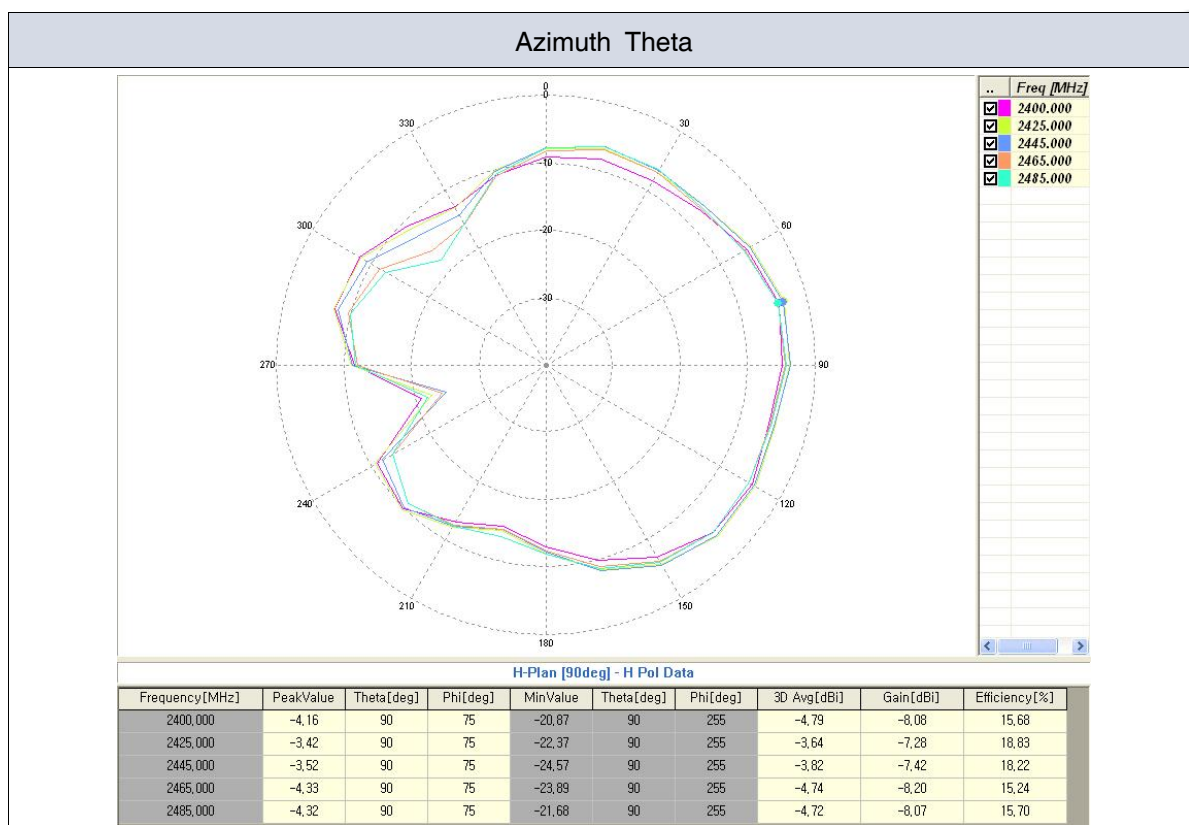
ITEM	SPEC
Frequency Range [MHz]	2400 ~ 2480
Lower frequency(2400MHz) SWR [Min~Max]	1.0 ~ 2.5 : 1 (Typ 1.3 : 1)
Upper frequency(2480MHz) SWR [Min~Max]	1.0 ~ 2.5 : 1 (Typ 1.3 : 1)

4.4 S11 Graph of Test Fixture Condition CTQ

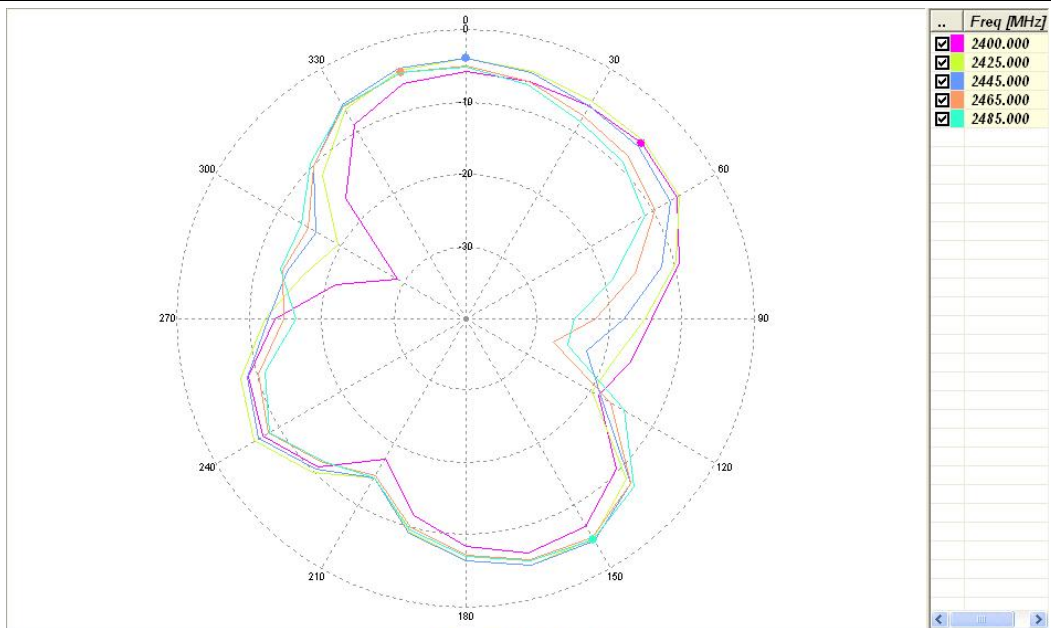


4.5 Radiation Pattern

Azimuth Plane	Elevation1 Plane	Elevation2 Plane
		
Theta	Vertical field of measured plane	
Phi	Horizontal field of measured plane	



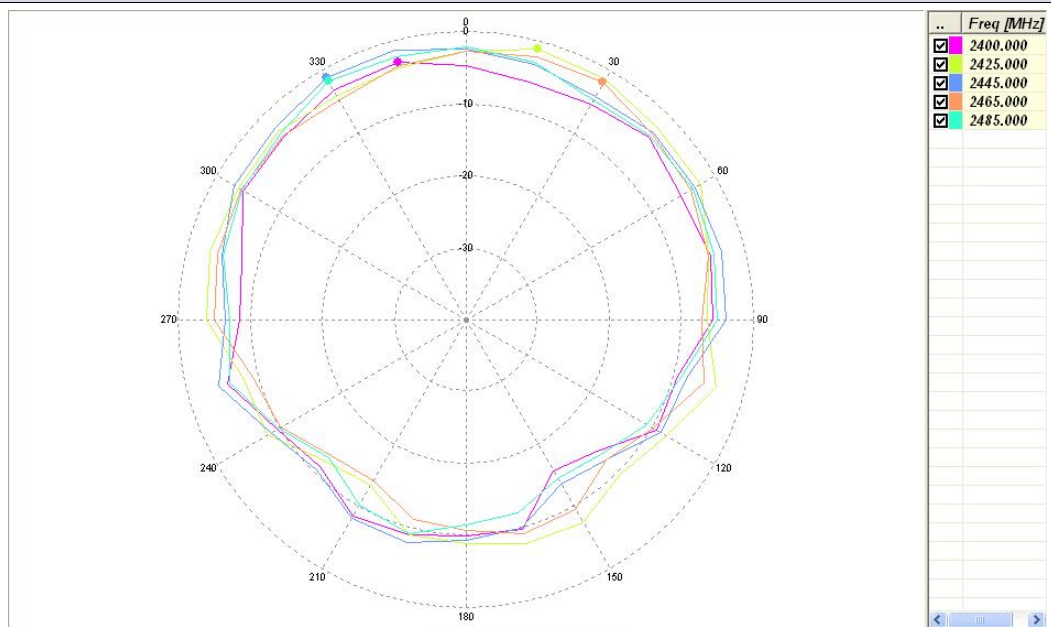
Azimuth Phi



H-Plan [90deg] - V Pol Data

Frequency[MHz]	PeakValue	Theta[deg]	Phi[deg]	MinValue	Theta[deg]	Phi[deg]	3D Avg[dBi]	Gain[dBi]	Efficiency[%]
2400,000	-5,49	90	45	-28,98	90	300	-4,79	-8,93	12,90
2425,000	-3,95	90	0	-19,84	90	120	-3,64	-7,54	17,74
2445,000	-3,88	90	0	-22,75	90	105	-3,82	-7,68	17,16
2465,000	-4,72	90	345	-27,45	90	105	-4,74	-8,65	13,75
2485,000	-4,74	90	150	-25,33	90	105	-4,72	-8,78	13,36

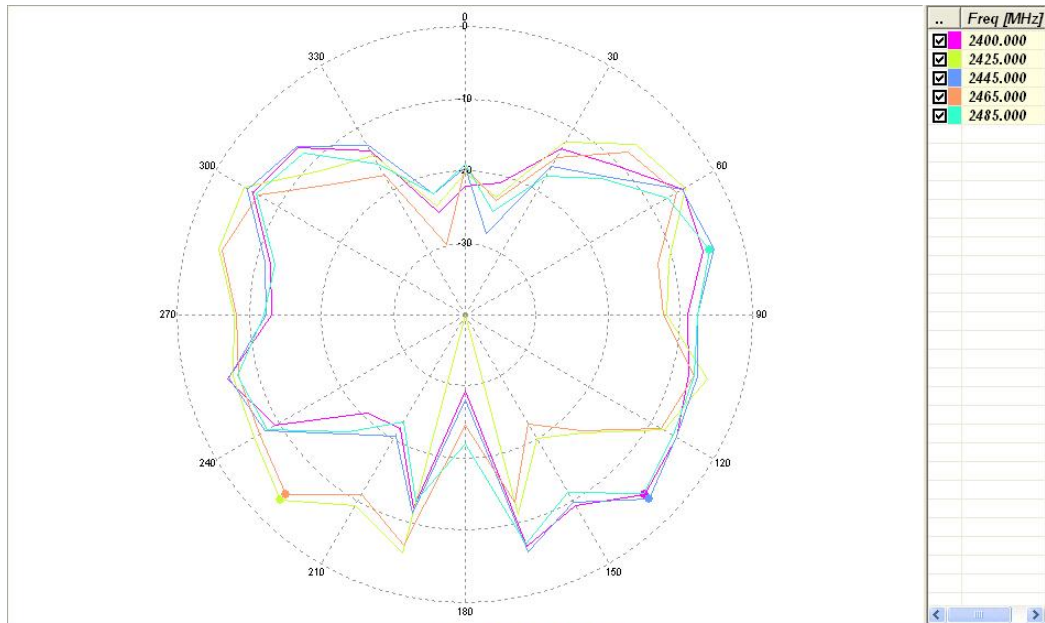
Elevation1 Theta



E-Plan [0deg] - V Pol Data

Frequency[MHz]	PeakValue	Theta[deg]	Phi[deg]	MinValue	Theta[deg]	Phi[deg]	3D Avg[dBi]	Gain[dBi]	Efficiency[%]
2400,000	-2,95	345	0	-15,76	150	0	-4,79	-6,43	22,88
2425,000	-1,10	345	0	-13,38	150	0	-3,64	-4,69	34,10
2445,000	-1,14	330	0	-13,64	150	0	-3,82	-4,77	33,42
2465,000	-1,85	330	0	-14,26	150	0	-4,74	-5,61	27,59
2485,000	-1,65	330	0	-14,60	150	0	-4,72	-5,54	28,03

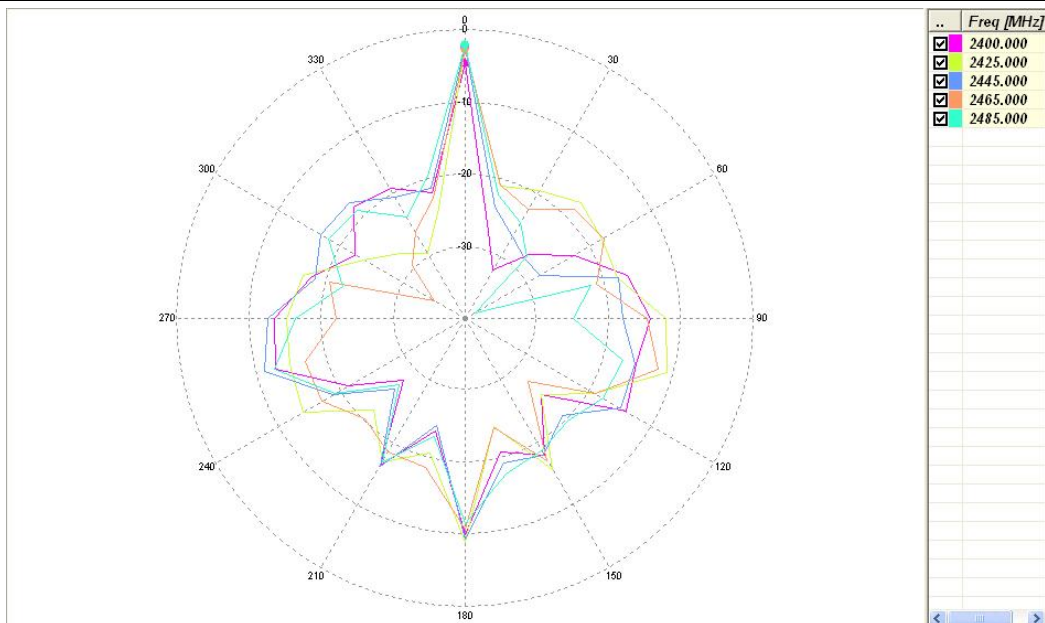
Elevation1 Phi



E-Plan [0deg] - H Pol Data

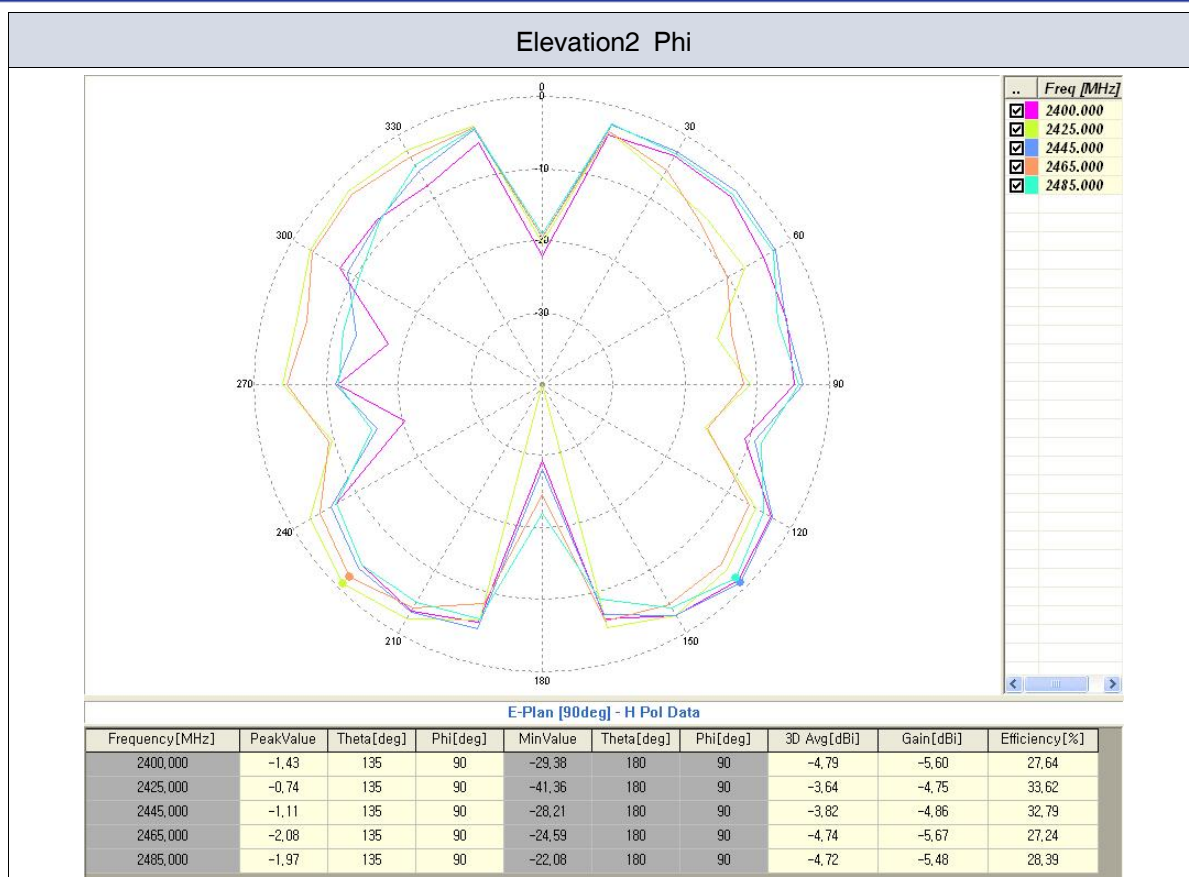
Frequency[MHz]	PeakValue	Theta[deg]	Phi[deg]	MinValue	Theta[deg]	Phi[deg]	3D Avg[dBi]	Gain[dBi]	Efficiency[%]
2400.000	-4.70	135	0	-29.38	180	0	-4.79	-9.02	12.65
2425.000	-3.64	135	0	-41.36	180	0	-3.64	-8.22	15.18
2445.000	-3.92	135	0	-28.30	15	0	-3.82	-8.47	14.33
2465.000	-4.81	135	0	-29.83	15	0	-4.74	-9.45	11.46
2485.000	-4.85	75	0	-25.10	15	0	-4.72	-9.47	11.41

Elevation2 Theta



E-Plan [90deg] - V Pol Data

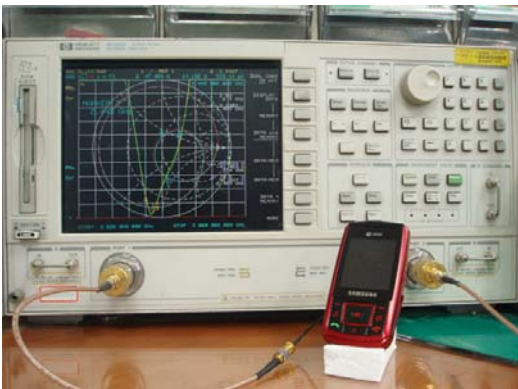
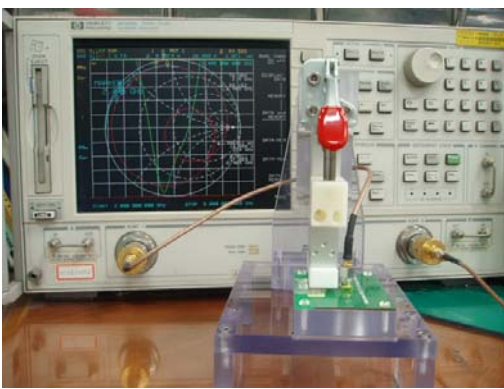
Frequency[MHz]	PeakValue	Theta[deg]	Phi[deg]	MinValue	Theta[deg]	Phi[deg]	3D Avg[dBi]	Gain[dBi]	Efficiency[%]
2400.000	-4.68	0	90	-32.20	30	90	-4.79	-14.80	3.42
2425.000	-2.65	0	90	-29.53	30	90	-3.64	-13.40	4.68
2445.000	-2.36	0	90	-28.29	45	90	-3.82	-13.48	4.60
2465.000	-2.66	0	90	-34.90	60	90	-4.74	-14.22	3.89
2485.000	-2.12	0	90	-38.34	60	90	-4.72	-14.03	4.06



5. Measurement Process

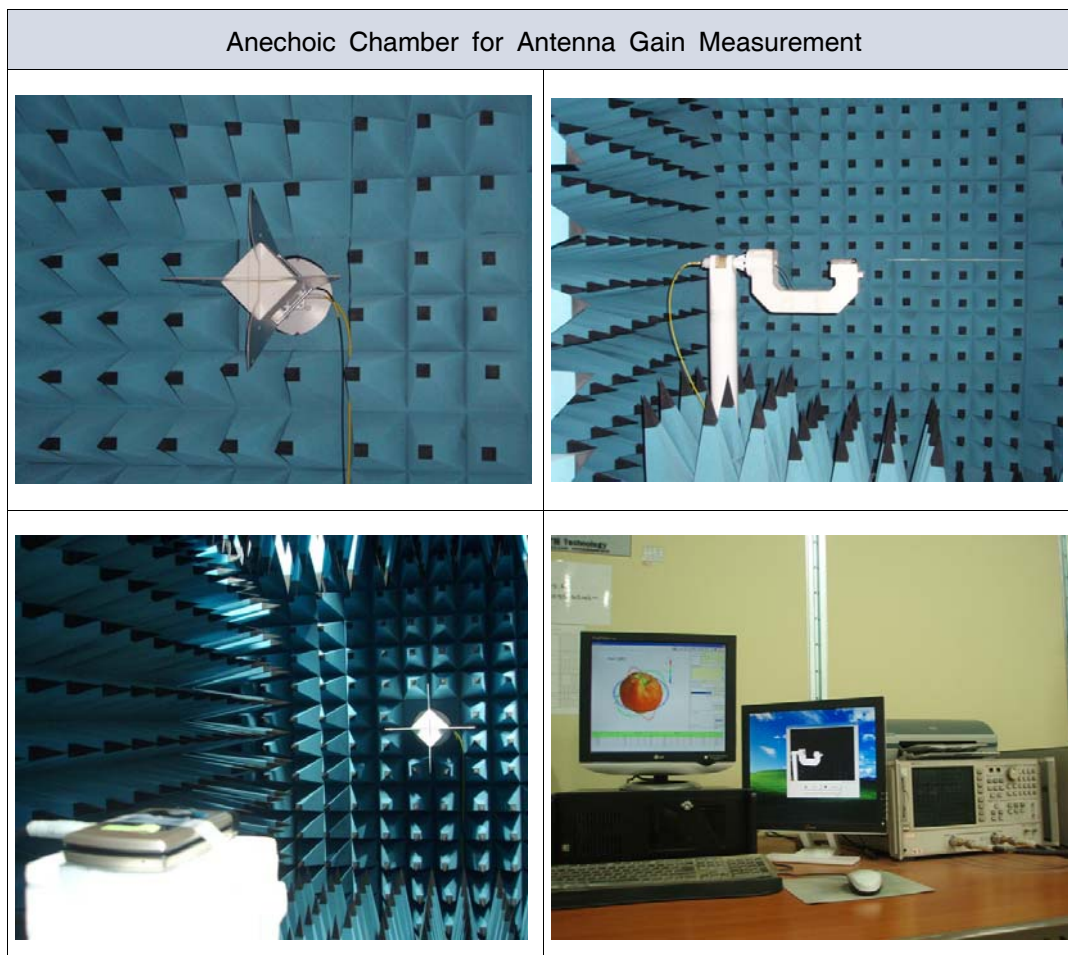
5.1 SWR/Return loss

Use Network Analyzer when measuring SWR/Return loss and selecting standard SPL,
Use automatic inspection equipment when selecting superior and inferior goods.

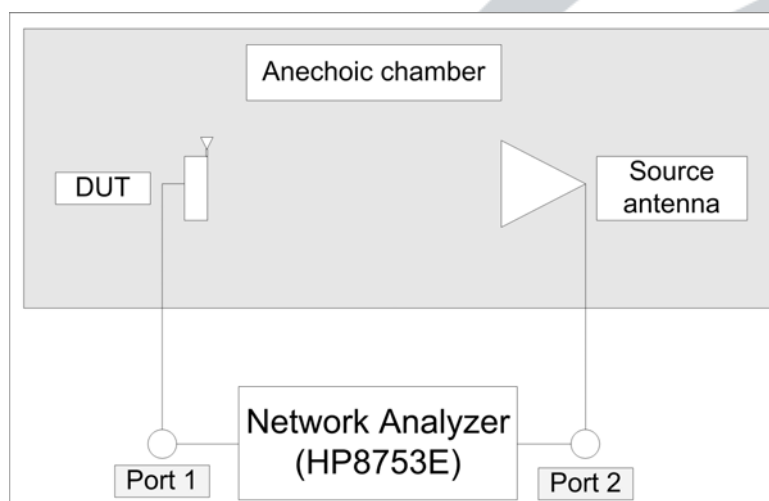
	Set Condition	Test Fixture Condition
Network Analyzer	Agilent HP8753D	Agilent HP8753D or Advantest R3765CH
Cable	RF cable(300mm)	RF cable(300mm)
Test condition		

5.2 Gain

Antenna gain is measured in the Anechoic Chamber of this company, using set above of 4.1 list.

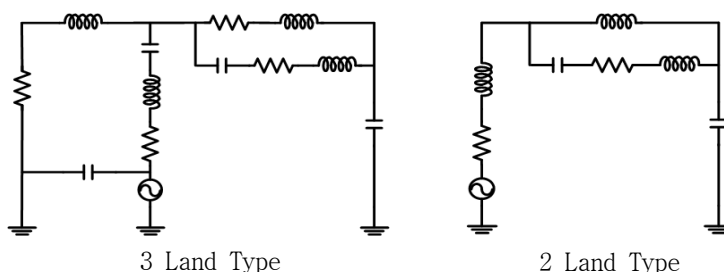


5.3 Gain test block diagram



6. Internal Block Diagram

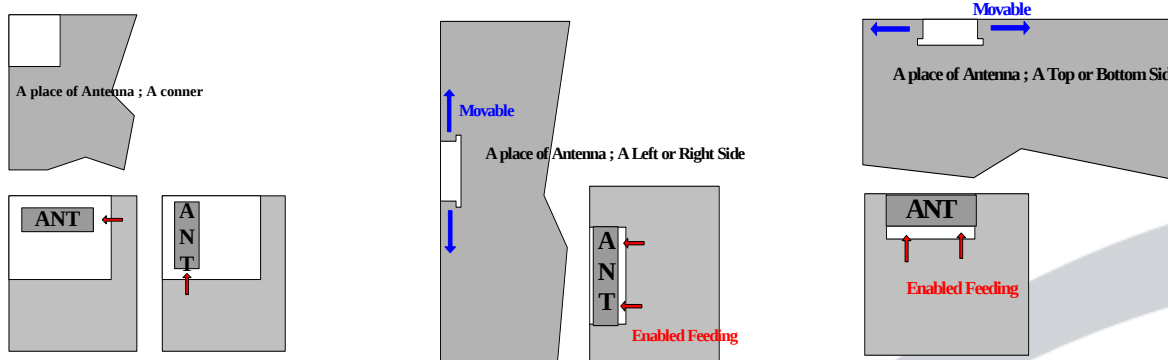
This product is made of the dielectric block and RF part materialized the characteristics by structural change of Ag pattern on the brick of dielectric block and conditioning value of the structural equivalent circuit.



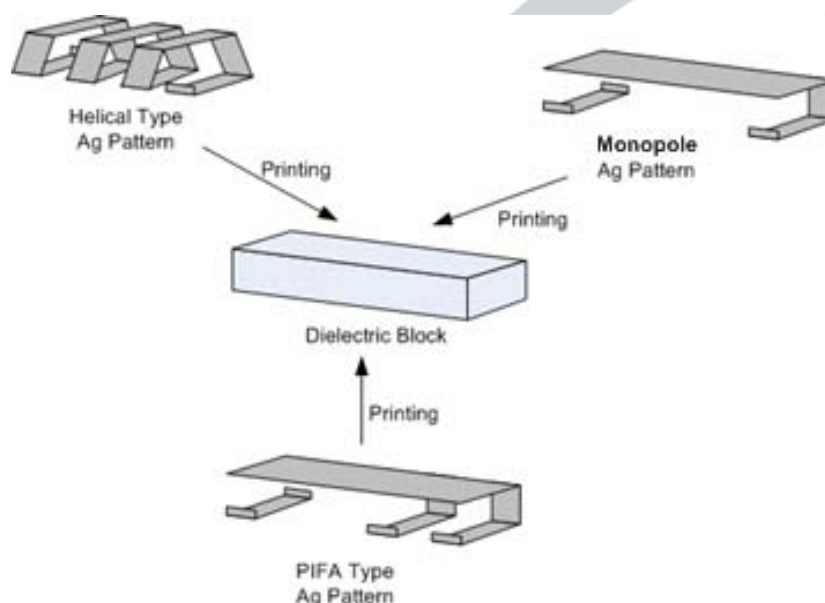
7. Basis Action / Application Note

This product is the internal dielectric chip antenna of radio communication, converts the electric signal advanced along by transmission line into free space wave.

This product will be mounted wherever you want and the design is revised by mount condition. But require attention to select the mount position, because this product is the radiation part and changed characteristics by boundary condition,

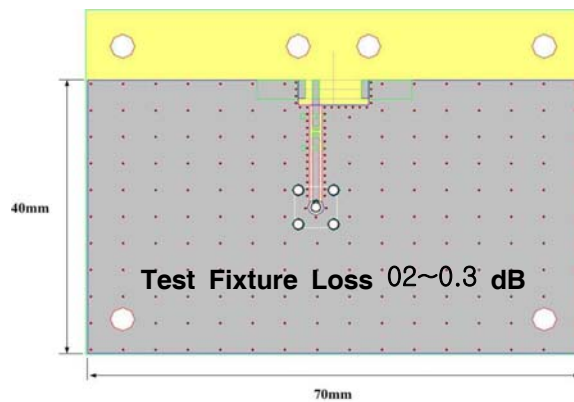


As the following, this product is easy to revise the various types for the boundary condition.



8. Measurement Jig SPEC

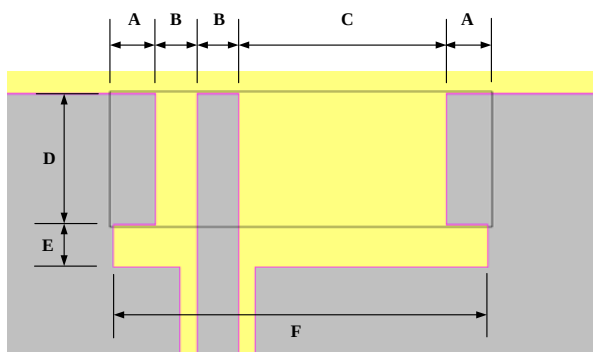
8.1 Test Fixture And GROUND Condition



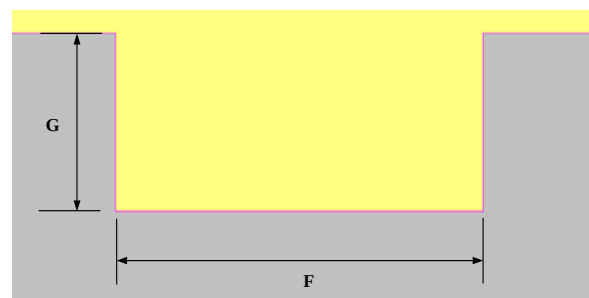
※ Ev B'd and Test Fixture Jig is the same

(Contact way of Ev B'd is soldering, Test Fixture is copper contact way)

8.2 PCB Layout & Soldering Pad Dimension



Top Layout



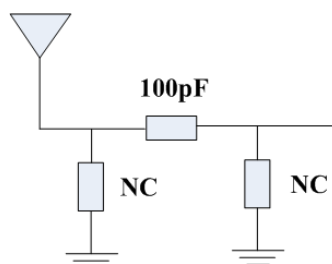
Bottom Pattern

Parameter	A	B	C	D	E	F	G
Value[mm]	1.1	1.0	5.0	3.2	1.0	9.0	4.2

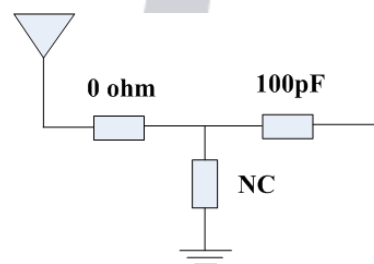
Unit ; mm

Unless specified tolerances are ± 0.1

8.3 Matching Circuit And Reference Value



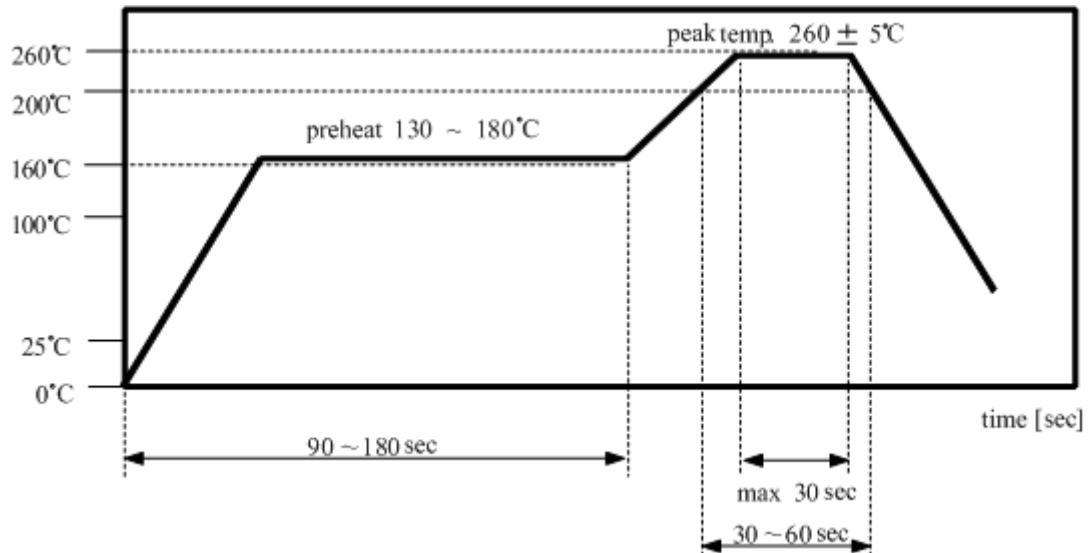
π Matching



T Matching

9. REFLOW PROFILE

9.1 Reflow Soldering



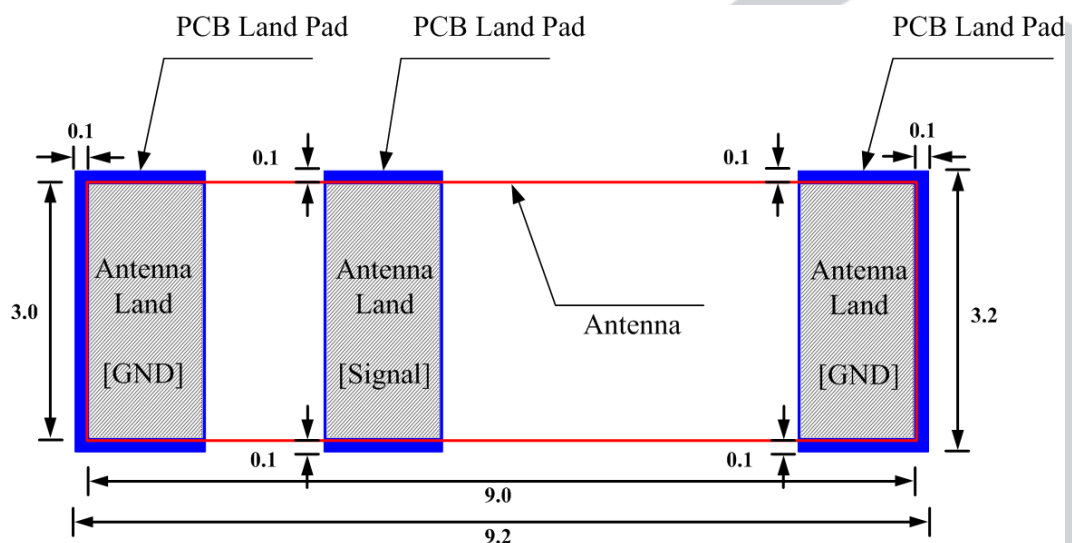
9.2 Manual Soldering

Pre-heating Temperature : 120°C , 60 ~ 300 sec.

Soldering Temperature : 340°C±5°C , 5sec max per each terminal

9.3 PCB Pattern Design

As the following, the PCB land pattern lays out 0.1mm outside land pattern of antenna more than indicated antenna land dimension



10. Primary Inspection List

Item	Electrical Characteristic[MHz] 		Size [mm]		
Standard	VSWR 3.0 MAX		W=3.0±0.1	L=9.0±0.1	T=1.2±0.1
	2400MHz	2480MHz			
1	1.28	1.26	3.02	9.00	1.22
2	1.24	1.32	3.01	9.01	1.23
3	1.29	1.30	3.03	9.03	1.21
4	1.25	1.32	3.03	9.01	1.22
5	1.28	1.22	3.02	9.00	1.20
6	1.26	1.29	3.01	9.02	1.21
7	1.24	1.29	3.02	9.00	1.21
8	1.20	1.38	3.03	9.00	1.22
9	1.24	1.26	3.02	9.01	1.21
10	1.22	1.32	3.01	9.02	1.20
11	1.24	1.27	3.03	9.01	1.23
12	1.29	1.24	3.02	9.00	1.20
13	1.23	1.20	3.02	9.02	1.22
14	1.32	1.24	3.02	9.01	1.23
15	1.24	1.27	3.03	9.00	1.21
16	1.15	1.33	3.01	9.01	1.20
17	1.17	1.27	3.02	9.02	1.22
18	1.25	1.29	3.04	9.01	1.20
19	1.30	1.25	3.02	9.01	1.22
20	1.28	1.24	3.01	9.00	1.21
Min	1.15	1.20	3.02	9.00	1.20
Max	1.32	1.38	3.04	9.02	1.23
X	1.24	1.27	3.02	9.01	1.21
σ	0.04	0.04	0.01	0.01	0.01
Cpk	1.93	1.71	2.71	3.49	3.04
Decision	OK	OK	OK	OK	OK

11. Reliability Condition

11.1 Environment Test

ITEM	TEST CONDITION	LIMIT
High Temperature Action	85℃±3℃, 1hr	After test, Must meet the characteristics spec of 4.4 list
High Temperature Resistance	+85℃±3℃, 120hr±2hr	
Low Temperature Action	-40℃±3℃, 1hr	
Low Temperature Resistance	-40℃±3℃, 120hr±2hr	
Humidity Action	+85±3℃, RH85%	
Humidity Resistance	+85±3℃, RH85%, 120hr±2hr	

11.2 Thermal shock test , Reflow test

ITEM	TEST CONDITION	LIMIT
Thermal shock	condition : -40℃±3℃/1min ↔ +85℃±3℃/1min Test Cycle : 32 cycle Temperature change time : within 5 min	After test, Must meet the characteristics spec of 4.4 list
Reflow	Pre Heating : 200±5℃, 30~60 sec Peak Heating : 260℃±5℃, 30sec Max	

11.3 Mechanical Test

ITEM	TEST CONDITION	LIMIT
Vibration	Freq : 10~500Hz , Acceleration : 10 ×9.8 ^{m/s²} (G) Sweep time : 15 min , X.Y.Z each 5 times	After test, Must meet the characteristics spec of 4.4 list
Drop	18 times free fall Using the drop jig 152cm high Jig : 120g±20g Plastic Jig Bottom : Concrete or Iron	

11.4 MSL LEVEL Test

1) JEDEC J-STD-020C Test

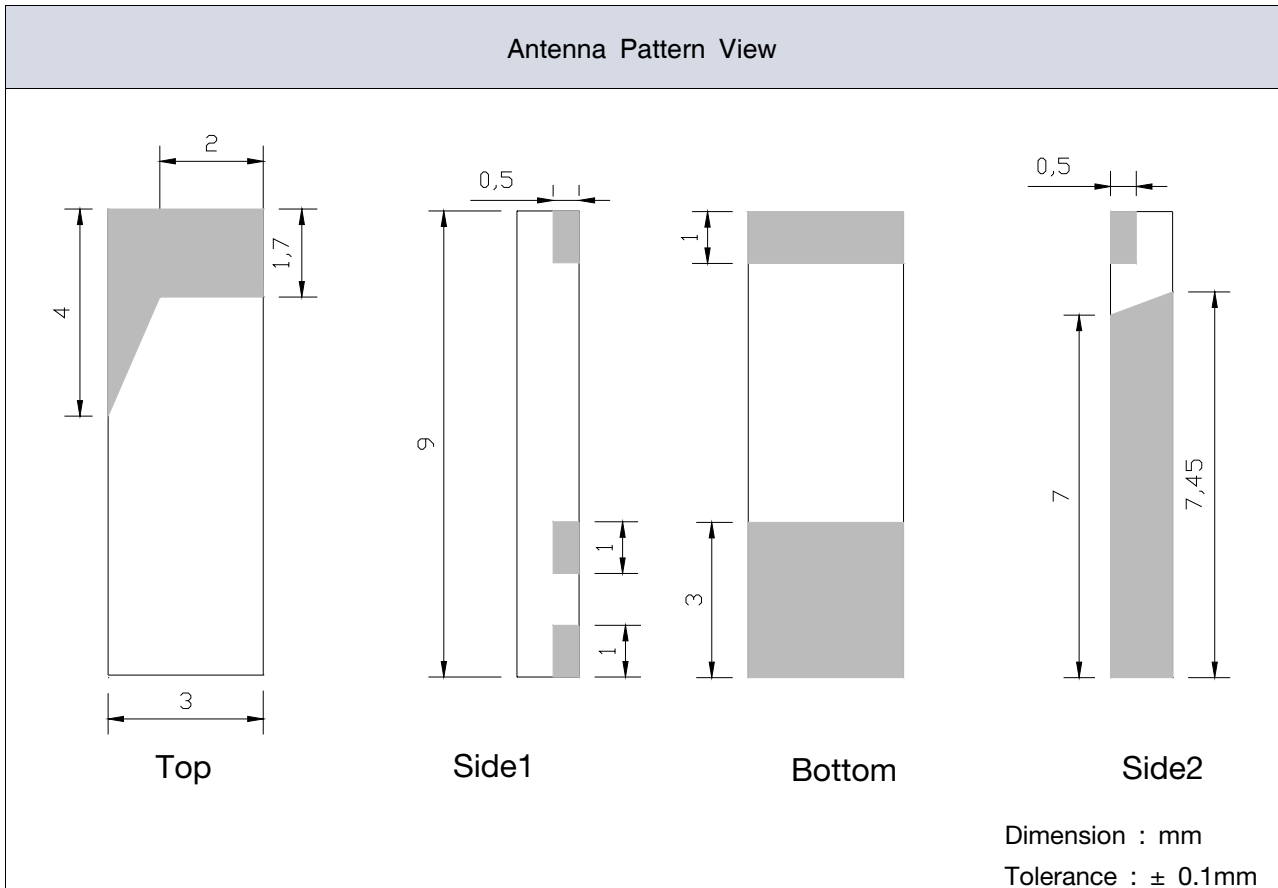
	Floor Life		Soak Requirements	
	Time	Conditions	Time	Conditions
1	Unlimited	= < 30℃/85%RH	168+5/-0	= < 85℃/85%RH

2) Test Condition

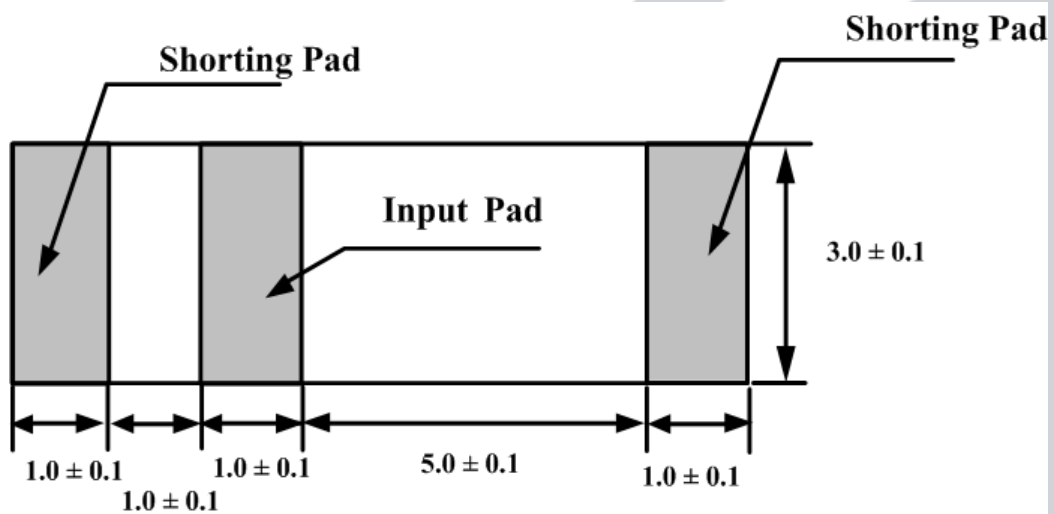
ITEM	Conditon	LIMIT
Soak Requirements	After leaving +85±3℃, RH85% 168hr±2hr 2 times Reflow without aging	After test, Must meet the characteristics spec of 4.4 list

12. Mechanical Characteristics

12.1 Antenna Pattern Dimension



12.2 Pin name

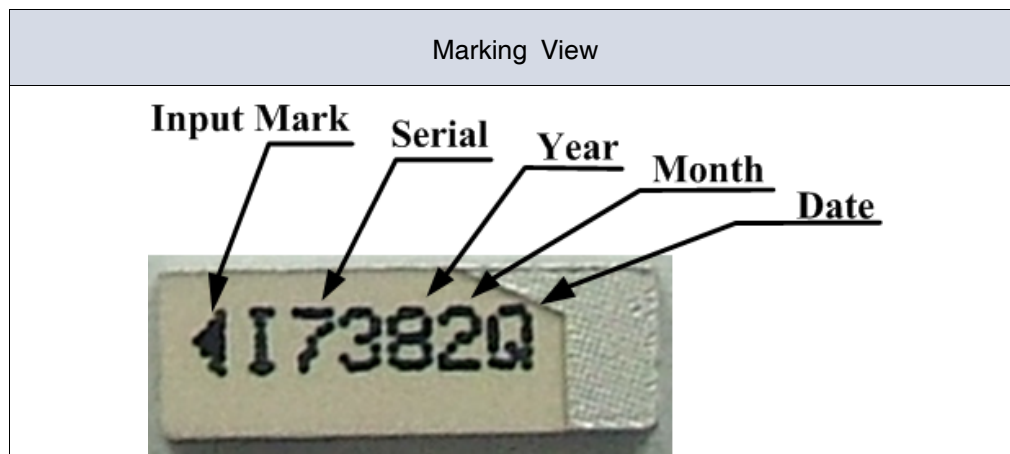


12.3 Lot number notation

8	2	Q
①	②	③

- ① Year : 7 - 2007 ····
- ② Month : 1 - January, 2 - February ···· 9 - September, A - October, B - November ··
- ③ Date : 1 - 1st , 2 - 2nd ···· A - 10th, B - 11th ····

12.4 Marking



◀	<u>1 7 3</u>	<u>8</u>	<u>2</u>	<u>Q</u>
①	②	③	④	⑤

- ① Input Signal
- ② Serial
- ③ Year; 1 - 2001, 2 - 2002, ···· 7 - 2007 ····
- ④ Month ; 1 - January, 2 - February ·· 9 - September, A - October, B - November ··
- ⑤ Date : 1 - 1st , 2 - 2nd ···· A - 10th, B - 11th ····

12.5 Marking type

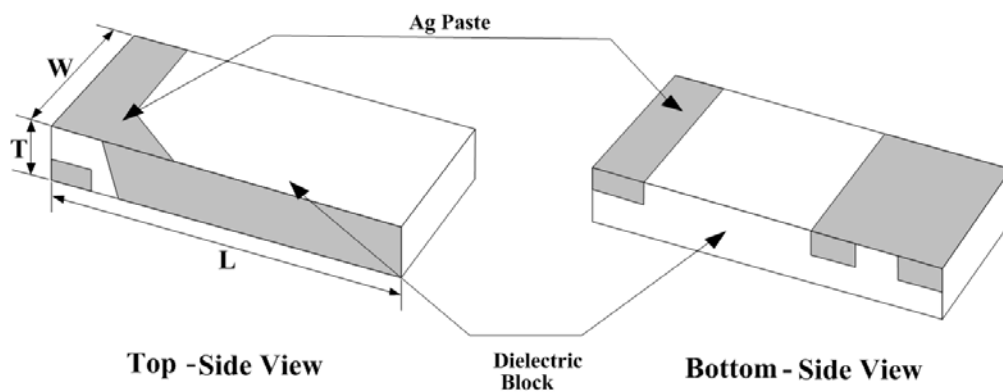
Ink marking - Using Black Ink

13. Structure and Material

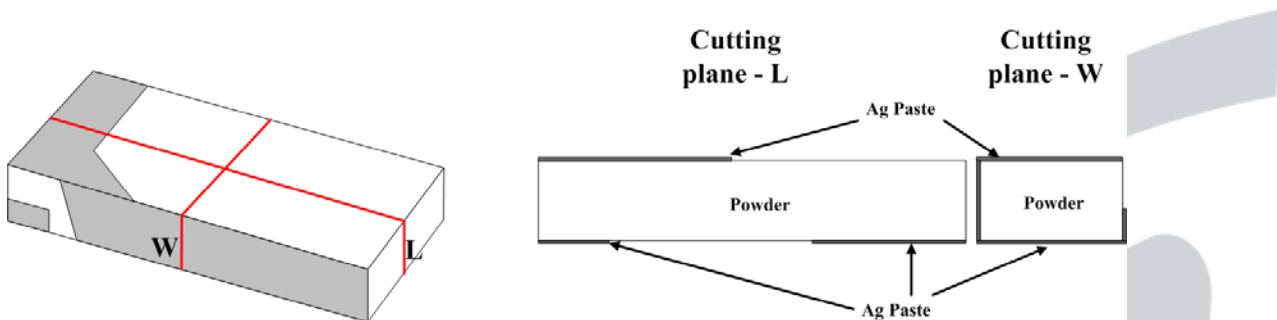
13.1 materialization method

Chip antenna forms the pattern with Ag paste on the brick of dielectric block and materializes the characteristics

13.2 Struture



13.3 Internal cross section



13.4 Material

ITEM	Material	Maker	Printing pattern SPEC
Dielectric Block	Powder	Fuji	
PATTERN	Ag Paste	METECH	Thickness : TYP 10 μ m
PAD	Ag paste	METECH	Thickness : Min 10 μ m (TYP 16~20 μ m)

14. Attention

14.1 Temperature Condition

	Range of Temperature	Unit
Application temperature	-40 ~ +85	℃
Keeping temperature	-40 ~ +85	℃

14.2 Temperature Test Condition

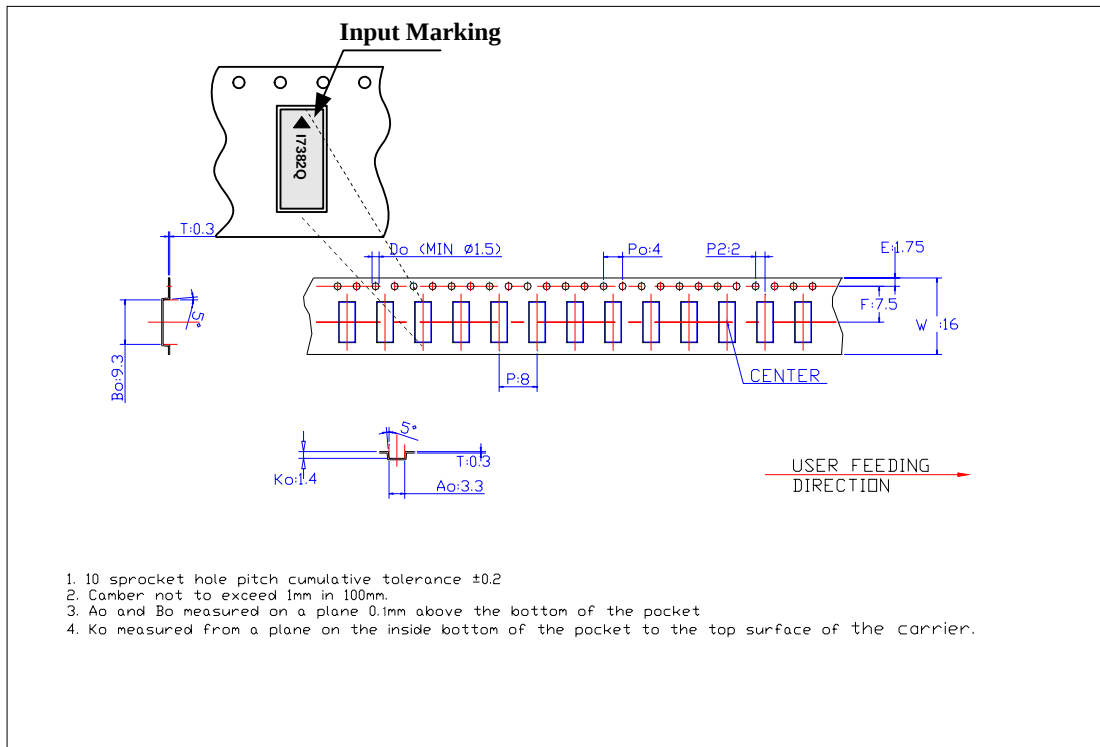
	Condition	Range of Temperature
Application temperature	Low	24hr normal action at -75℃
	High	24hr normal action at +150℃
Keeping temperature	Low	normal action when left for 1000hr at -75℃
	High	normal action when left for 1000hr at +85℃

* Because of the keeping temperature problem, no admission when left over +85℃

15. Packing

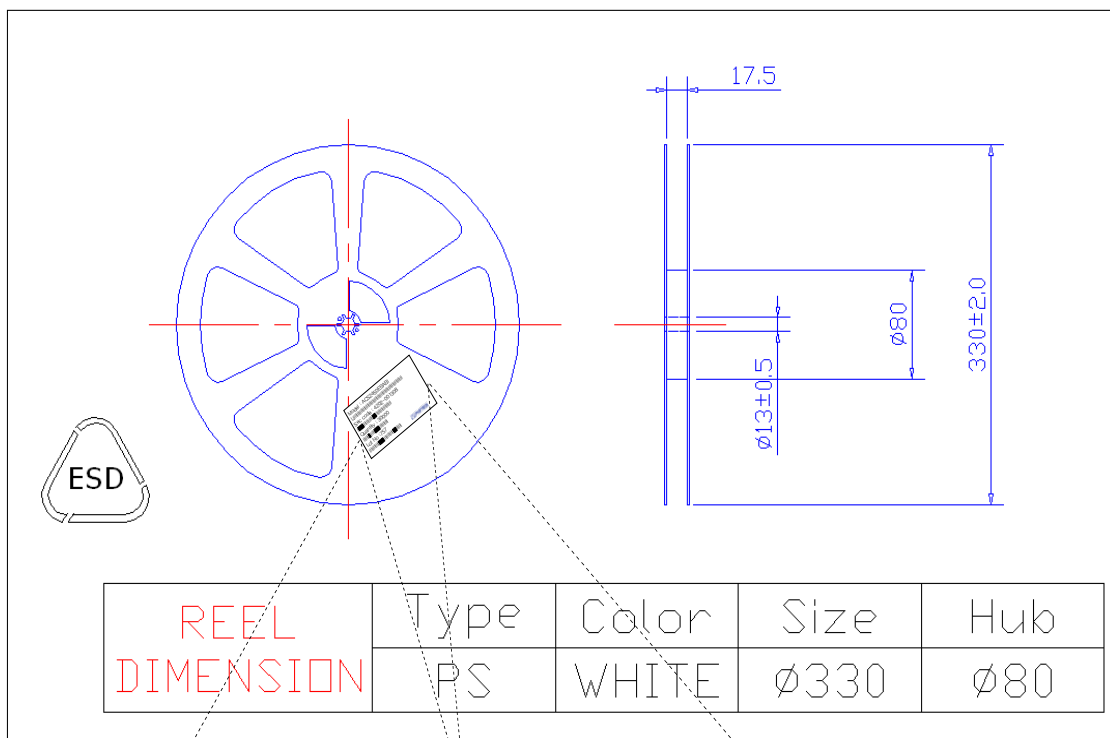
15.1 Carrier/Reel

ITEM	Material	Surface Resistance	electrostatic emission	Packing method
Carrier tape	A-PET	Typical $10^8 \Omega$	10V MAX	Heat press
Cover tape	PET	Typical $10^8 \Omega$	30V MAX	
Reel	PS	Typical $10^8 \Omega$	30V MAX	-



DKC DWG. No.	D-1608-023
DIMENSIONAL UNIT	MM
UNTOLERANCED DIMENSION	± 0.1
CAD FILE NAME	050423
DESIGNED BY	K. M. J
SCALE	1/1
TITLE	CARRIER TAPE 3.0*9.0*1.2P
PART.	CARRIER TAPE
MATERIAL	C-PET
LENGTH	46.81
COUNT	5850P

NAME	SPEC.
W	16.0 ± 0.2
E	1.75 ± 0.1
F	7.5 ± 0.1
Do	1.5 ± 0.1
P	8.0 ± 0.1
Po	4.0 ± 0.1
P2	2.0 ± 0.1
Ao	3.3 ± 0.1
Bo	9.3 ± 0.1
Ko	1.4 ± 0.1
T	0.3 ± 0.05



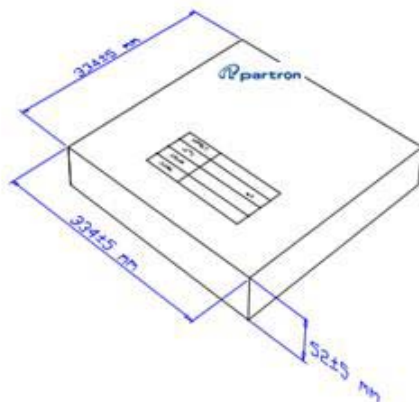
Model : ACS2450ICA173
 Quantity : 5000
 Lot No : 82Q



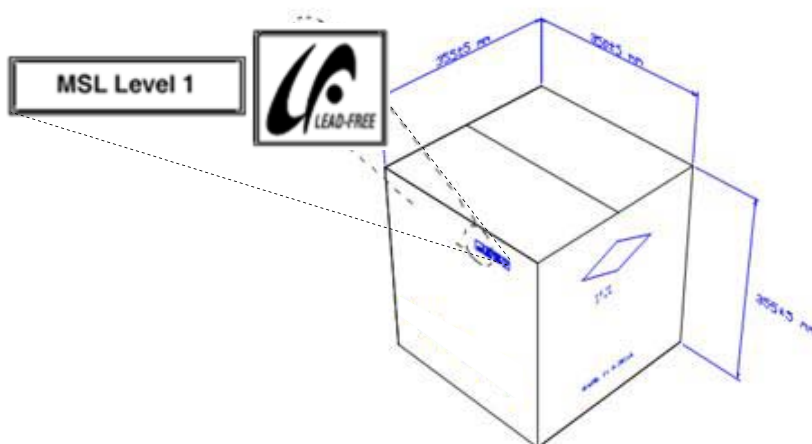
MSL Level 1



15.2 BOX



Material : SK/S/K-B
Corrugated cardboard



15.3 Actual packing Picture



Reel



Internal Box



External Box



Reel / Internal Box label



External Box label

16. Process Control

Product			Issued/Revision		Process Control				Record	By designed	By checked	By approved		
CHIP ANTENNA			Issued	04.04.06					Revised	05.04.03	PRCP-C001			
Input Materials	FLOW CHART		Process name	Management of Factors					Management of quality					
	preparation	Main Process		Equipment Name	Checked	Condition	Cycle of management	Record	Checked Item	Margin	Method of Inspection	Cycle of management	Record	Action
Ceramic POWDER		◇	Import Inspection						shrinking rate permittivity	refer to Guide Sheet	Micrometer Network	10ea/LOT	C/sheet	Return
POWDER lubricant	○		powder	Mixer					mixing	POWDER lubricant	Scale	PER MIXING	-	Exhaust
		○	Shaping	Press	pressure Mold Condition	refer to Guide Sheet	Per LOT 1/day	parameter C/SHEET	dimension weight density aspect	refer to Guide Sheet	Micrometer scale Calculated Visual	5/100EA 10ea/lot	LOT CARD	Exhaust
		○	Plasticity	Plasticity Hole	SETTER Outside Temperature PROFILE	refer to Guide Sheet	all 2/day 1/month	C/sheet						
		◇	Block						wide length shape	refer to Guide Sheet	Micrometer Calipers Visual Inspection	20ea/LOT 20ea/LOT all	C/sheet	Exhaust
AG PASTE		○	SIDE1 PAD Printing	Printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN Dimension aspect	refer to Guide Sheet	Microscope	10ea/3Jig	c/sheet	Rework
		○	Dry	Dryer Dry Jig	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	all	Lot card	Rework

Product			Issued/Revision		Process Control				Record	By designed	By checked	By approved		
CHIP ANTENNA			Issued	04.04.06					PRCP-C001					
Input Materials	FLOW CHART		Process name	Management of Factors					Management of quality					
	preparation	Main Process		Equipment Name	Checked	Condition	Cycle of management	Record	Checked Item	Margin	Method of Inspection	Cycle of management	Record	Action
AG PASTE			SIDE 2 PAD Printing	Printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN Dimension aspect	refer to Guide Sheet	Microscope	10ea/3Jig	c/sheet	Rework
			Dry	Dryer Dry Jig	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	all	Lot card	Rework
			Baking	Baking Hole mesh net	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter C/Sheet	Breakage Pollution	refer to Guide Sheet	Visual Inspection	all	Lot card	Exhaust Rework
AG PASTE			TOP printing	Printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN dimension	refer to Guide Sheet	measure	10ea/3Jig	c/sheet	Rework
			Dry	Dryer Dry Jig	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	all	Lot card	Rework
AG PASTE			BOTTOM PAD Printing CTQ	printer screen	Squeeze velocity/presure SNAP	refer to Guide Sheet	1/day	-	PATTERN dimension aspect	refer to Guide Sheet	measure Microscope	10ea/3Jig	c/sheet	Rework

Product			Issued/Revision		Process Control				Record	By designed	By checked	By approved		
CHIP ANTENNA			Issued	04.04.06					Revised	05.04.03	PRCP-C001			
Input Materials	FLOW CHART		Process name	Management of Factors					Management of quality					
	preparation	Main Process		Equipment Name	Checked	Condition	Cycle of management	Record	Checked Item	Margin	Method of Inspection	Cycle of management	Record	Action
			Dry	Dryer Dry Jig	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter	Dry Condition Printed condition breakage	refer to Guide Sheet	Visual Inspection	all	Lot card	Rework
			Baking	Baking Hole mesh net	Temperature Belt speed	refer to Guide Sheet	1/week	Parameter C/Sheet	Breakage Pollution	refer to Guide Sheet	Visual Inspection	all	Lot card	Exhaust Rework
			aspect inspection						aspect	Reference SPL refer to Guide Sheet	Visual Inspection microscope	all	Lot card production diary	Exhaust repair
			MARKING	Marking Machine					marking	Reference SPL	Visual Inspection	all	Lot card production diary	Rework Exhaust
			Electrical Characteristic	NETWORK Inspection Jig	proofreading Condition	refer to Guide Sheet	1/2hour	C/sheet	Electrical Characteristic	refer to Guide Sheet	Network	all	Lot card production diary	Exhaust repair
			aspect inspection						aspect dimension	Reference SPL refer to Guide Sheet	Visual Inspection microscope	all	Lot card production diary	Exhaust repair
Carrier cover reel			Taping						Quantity Direction aspect	refer to Guide Sheet	Manual	all	Lot card production diary	Rework
			shipper inspection	NETWORK Inspection Jig	proofreading Condition	refer to Guide Sheet	1/person	C/sheet	Electrical Characteristic aspect packing	refer to Guide Sheet	Network microscope Visual Inspection	refer to Guide Sheet	Result Paper	return Exhaust
packing box label			packing	bar code printer					packing P/N Quantity	refer to Guide Sheet	Visual Inspection	all	-	Rework
			packing inspection						packing P/N Quantity	refer to Guide Sheet	Visual Inspection	all	-	return

17. RoHS Data

1) Ceramic Powder

SGS

Test Report No.: CE/2007/76776 Date: 2007/08/03 Page: 1 of 3

FUJII TITANIUM IND. CO., LTD.
12-8, SENGEN-CHO, HIRATSUKA-CITY, KANAKAWA-PREF. JAPAN.

The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description: MIXTURE OF MAGNESIUM SILICATE, STRONTIUM
Style Item No.: XMS-08 (B)
Sample Receiving Date: 2007/07/27
Testing Period: 2007/07/27 TO 2007/08/03

Test Requested: In accordance with the RoHS Directive 2002/95/EC, and its amendment directives.

Test Method: With reference to IEC 62321, Ed.1 111/54/CDV Procedures for the Determination of Levels of Regulated Substances in Electrotechnical Products.

(1) Determination of Cadmium by ICP-AES.
(2) Determination of Lead by ICP-AES.
(3) Determination of Mercury by ICP-AES.
(4) Determination of Hexavalent Chromium for non-metallic samples by UV/Vis Spectrometry.
(5) Determination of PBB and PBDE by GC/MS.

Test Result(s): Please refer to next page(s).

David Yen, M.B. Operation Manager
Signed for and on behalf of
SGS TAIWAN LTD.
Chemical Laboratory - Taipei

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SGS Taiwan Ltd. (TSC) 110, 110-1, Hsu Feng Road, Neihu Industrial Zone, Taipei county, Taiwan.
8866-2 2289599 8866-2 2289-3257 www.sgs.com.tw

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Test Report No.: CE/2007/76776 Date: 2007/08/03 Page: 2 of 3

FUJII TITANIUM IND. CO., LTD.
12-8, SENGEN-CHO, HIRATSUKA-CITY, KANAKAWA-PREF. JAPAN.

Test results by chemical method (Unit: mg/kg)

Test Item (s):	Method (Refer to)	Result No.1	MDL
Cadmium (Cd)	(1)	n.d.	2
Lead (Pb)	(2)	n.d.	2
Mercury (Hg)	(3)	n.d.	2
Hexavalent Chromium Cr(VI) by alkaline extraction	(4)	n.d.	2
Sum of PBBs		n.d.	-
Monobromobiphenyl		n.d.	5
Dibromobiphenyl		n.d.	5
Tribromobiphenyl		n.d.	5
Tetrabromobiphenyl		n.d.	5
Pentabromobiphenyl		n.d.	5
Hexabromobiphenyl		n.d.	5
Heptabromobiphenyl		n.d.	5
Octabromobiphenyl		n.d.	5
Nonabromobiphenyl		n.d.	5
Decabromobiphenyl		n.d.	5
Sum of PBDEs (Mono to Nona) (Note 4)	(5)	n.d.	-
Monobromobiphenyl ether		n.d.	5
Dibromobiphenyl ether		n.d.	5
Tribromobiphenyl ether		n.d.	5
Tetrabromobiphenyl ether		n.d.	5
Pentabromobiphenyl ether		n.d.	5
Hexabromobiphenyl ether		n.d.	5
Heptabromobiphenyl ether		n.d.	5
Octabromobiphenyl ether		n.d.	5
Nonabromobiphenyl ether		n.d.	5
Decabromobiphenyl ether		n.d.	5
Sum of PBDEs (Mono to Deca)		n.d.	-

TEST PART DESCRIPTION:
NO.1: OFF-WHITE POWDER

Note: 1. mg/kg = ppm
2. n.d. = Not Detected
3. MDL = Method Detection Limit
4. According to 2005/717/EC DecaBDE is exempt.
5. "-" = Not Regulated

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8866-2 2289599 8866-2 2289-3257 www.sgs.com.tw

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Test Report No.: CE/2007/76776 Date: 2007/08/03 Page: 3 of 3

FUJII TITANIUM IND. CO., LTD.
12-8, SENGEN-CHO, HIRATSUKA-CITY, KANAKAWA-PREF. JAPAN.



** End of Report **

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8866-2 2289599 8866-2 2289-3257 www.sgs.com.tw

2) Ag Paste

SGS

Test Report No. F690561LF-CT8AYAG7-22595 **Issued Date:** October 18, 2007 **Page 1 of 2**

To: METECH KOREA CO., LTD.
B-501 Dongyang Paragon office1 17-2 Jeongja-dong
Bundang-gu
Sungnam-city
Gyeonggi-do
Korea

The following merchandise was submitted and identified by the client as :

Product Name : Silver Paste

SGS File No. : AYA07-22595

Received Date : October 12, 2007

Test Performing Date : October 15, 2007

Test Performed : SGS Testing Korea tested the sample(s) selected by applicant with following results

Test Results : For further details, please refer to following page(s)

SGS Testing Korea Co. Ltd.

Pluto Kim
Monet Jeong
Billy Oh / Testing Person

Jeff Jang
Jeff Jang / Chemical Lab Mgr

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F052 Version2

SGS

Test Report No. F690561LF-CT8AYAG7-22595 **Issued Date:** October 18, 2007 **Page 2 of 2**

Sample No. : AYA07-22595.001

Sample Description : Silver Paste

Item No./Part No. : PCC11537HV

Heavy Metals

Test Item	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	US EPA 3052(1995), US EPA 6010B(1995), ICP	0.5	N.D.
Lead (Pb)	mg/kg	US EPA 3052(1995), US EPA 6010B(1995), ICP	5	N.D.
Mercury (Hg)	mg/kg	US EPA 3052(1995), US EPA 6010B(1995), ICP	2	N.D.
Hexavalent Chromium (Cr VI)	mg/kg	US EPA 3060A(1996), US EPA 7198A(1992), UV	1	N.D.

Picture of Sample as Received:

Sample Color : Gray



*** End ***

NOTE: (1) N.D. = Not detected. (=MDL)
(2) mg/kg = ppm
(3) MDL = Method Detection Limit
(4) - = No regulation
(5) * = Qualitative analysis (No Unit)
(6) Negative = Undetectable / Positive = Detectable

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3) Marking Ink

SGS
Test Report No. F690501LF-CTSA7-24109R1 Issued Date: November 05, 2007 Page 1 of 3

To: **IMAJE KOREA CO., LTD**
 #1302 7th Daerang Techno Town 459-11
 Gaseon-dong
 Gaseongnam-gu
 SEOUL
 Korea

The following merchandise was submitted and identified by the client as :

Product Name : S135E Black Ink
SGS File No. : AYA07-24109R1
Received Date : October 31, 2007
Test Performing Date : November 01, 2007
Test Performed : SGS Testing Korea tested the sample(s) selected by applicant with following results
Test Results : For further details, please refer to following page(s)
Buyer(s) : LG ELECTRONICS
Comments : This Report cancels and supercedes the Report No.F690501LF-CTSA7-24109 dated November 05, 2007 issued by SGS Testing Korea Co., Ltd. The Item No/part No. had changed from Gamet to S135E by customer's request.

SGS Testing Korea Co. Ltd.
Jeff Jang
 Jeff Jang / Chemical Lab Mgr

Pluto Kim
 Monal Jeong
 Billy Oh / Testing Person

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F692 Version2

SGS
Test Report No. F690501LF-CTSA7-24109R1 Issued Date: November 05, 2007 Page 2 of 3

Sample No. : AYA07-24109R1.001
Sample Description : S135E Black Ink
Item No./Part No. : S135E
Comments : Material is butanone.

Heavy Metals

Test Items	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	US EPA 3052(1995), US EPA 8210B(1995), ICP	0.5	N.D.
Lead (Pb)	mg/kg	US EPA 3052(1995), US EPA 8210B(1995), ICP	5	N.D.
Mercury (Hg)	mg/kg	US EPA 3052(1995), US EPA 8210B(1995), ICP	2	N.D.
Hexavalent Chromium (Cr VI)	mg/kg	US EPA 3060A(1995), US EPA 7196A(1992), UV	1	N.D.

Phthalates and related compounds

Test Items	Unit	Test Method	MDL	Results
Mandelonitrophenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromodiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Monobromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.

NOTE: (1) N.D. = Not detected (<MDL)
 (2) mg/kg = ppm
 (3) MDL = Method Detection Limit
 (4) - = No regulation
 (5) - = Qualitative analysis (No Unit)
 (6) Negative = Undetectable / Positive = Detectable

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F692 Version2

SGS
Test Report No. F690501LF-CTSA7-24109R1 Issued Date: November 05, 2007 Page 3 of 3

Picture of Sample as Received:
Sample Color : Black



--- End ---

NOTE: (1) N.D. = Not detected (<MDL)
 (2) mg/kg = ppm
 (3) MDL = Method Detection Limit
 (4) - = No regulation
 (5) - = Qualitative analysis (No Unit)
 (6) Negative = Undetectable / Positive = Detectable

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